

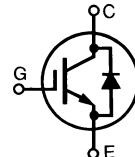
**Low $V_{CE(sat)}$ IGBT with Diode
High Speed IGBT with Diode**

**IXSH 30N60U1
IXSH 30N60AU1**

V_{CES}	I_{C25}	$V_{CE(sat)}$
600 V	50 A	2.5 V
600 V	50 A	3.0 V

Combi Packs

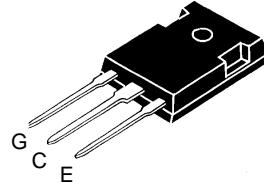
Short Circuit SOA Capability



Symbol	Test Conditions	Maximum Ratings		
V_{CES}	$T_J = 25^\circ\text{C}$ to 150°C	600	V	
V_{CGR}	$T_J = 25^\circ\text{C}$ to 150°C ; $R_{GE} = 1 \text{ M}\Omega$	600	V	
V_{GES}	Continuous	± 20	V	
V_{GEM}	Transient	± 30	V	
I_{C25}	$T_c = 25^\circ\text{C}$	50	A	
I_{C90}	$T_c = 90^\circ\text{C}$	30	A	
I_{CM}	$T_c = 25^\circ\text{C}$, 1 ms	100	A	
SSOA (RBSOA)	$V_{GE} = 15 \text{ V}$, $T_J = 125^\circ\text{C}$, $R_G = 33 \Omega$ Clamped inductive load, $L = 100 \mu\text{H}$	$I_{CM} = 60$ @ 0.8 V_{CES}	A	
t_{sc} (SCSOA)	$V_{GE} = 15 \text{ V}$, $V_{CE} = 360 \text{ V}$, $T_J = 125^\circ\text{C}$ $R_G = 33 \Omega$, non repetitive	10	μs	
P_c	$T_c = 25^\circ\text{C}$	200	W	
T_J		-55 ... +150	$^\circ\text{C}$	
T_{JM}		150	$^\circ\text{C}$	
T_{stg}		-55 ... +150	$^\circ\text{C}$	
M_d	Mounting torque	1.13/10	Nm/lb.in.	
Weight		6	g	
Maximum lead temperature for soldering 1.6 mm (0.062 in.) from case for 10 s		300	$^\circ\text{C}$	

Symbol	Test Conditions	Characteristic Values		
		($T_J = 25^\circ\text{C}$, unless otherwise specified)	min.	typ.
BV_{CES}	$I_c = 750 \mu\text{A}$, $V_{GE} = 0 \text{ V}$	600		V
$V_{GE(th)}$	$I_c = 2.5 \text{ mA}$, $V_{CE} = V_{GE}$	5		8 V
I_{CES}	$V_{CE} = 0.8 \cdot V_{CES}$ $V_{GE} = 0 \text{ V}$	$T_J = 25^\circ\text{C}$ $T_J = 125^\circ\text{C}$		500 μA 8 mA
I_{GES}	$V_{CE} = 0 \text{ V}$, $V_{GE} = \pm 20 \text{ V}$			$\pm 100 \text{ nA}$
$V_{CE(sat)}$	$I_c = I_{C90}$, $V_{GE} = 15 \text{ V}$ 30N60U1 30N60AU1			2.5 V 3.0 V

TO-247 AD



G = Gate, C = Collector,
E = Emitter, TAB = Collector

Features

- International standard package JEDEC TO-247 AD
- High frequency IGBT with guaranteed Short Circuit SOA capability
- IGBT and anti-parallel FRED in one package
- 2nd generation HDMOS™ process
- Low $V_{CE(sat)}$
 - for low on-state conduction losses
- MOS Gate turn-on
 - drive simplicity

Applications

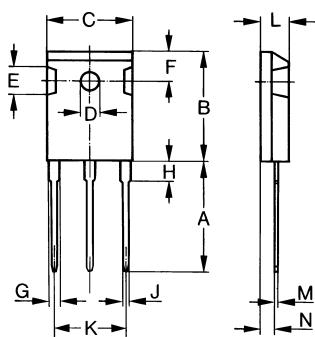
- AC motor speed control
- DC servo and robot drives
- DC choppers
- Uninterruptible power supplies (UPS)
- Switch-mode and resonant-mode power supplies

Advantages

- Space savings (two devices in one package)
- Easy to mount with 1 screw (isolated mounting screw hole)
- Reduces assembly time and cost
- High power density

Symbol	Test Conditions	Characteristic Values			
		($T_J = 25^\circ\text{C}$, unless otherwise specified)	min.	typ.	max.
g_{fs}	$I_C = I_{C90}$; $V_{CE} = 10 \text{ V}$, Pulse test, $t \leq 300 \mu\text{s}$, duty cycle $\leq 2 \%$	7	13	S	
$I_{C(on)}$	$V_{GE} = 15 \text{ V}$, $V_{CE} = 10 \text{ V}$		100	A	
C_{ies}	$V_{CE} = 25 \text{ V}$, $V_{GE} = 0 \text{ V}$, $f = 1 \text{ MHz}$	2760		pF	
C_{oes}		240		pF	
C_{res}		51		pF	
Q_g	$I_C = I_{C90}$, $V_{GE} = 15 \text{ V}$, $V_{CE} = 0.5 V_{CES}$	110	150	nC	
Q_{ge}		34	45	nC	
Q_{gc}		47	63	nC	
$t_{d(on)}$	Inductive load, $T_J = 25^\circ\text{C}$ $I_C = I_{C90}$, $V_{GE} = 15 \text{ V}$, $L = 100 \mu\text{H}$, $V_{CE} = 0.8 V_{CES}$, $R_G = 4.7 \Omega$ Remarks: Switching times may increase for V_{CE} (Clamp) $> 0.8 \cdot V_{CES}$, higher T_J or increased R_G	60		ns	
t_{ri}		130		ns	
$t_{d(off)}$		400		ns	
t_{fi}		30N60U1	400	ns	
E_{off}		30N60AU1	200	ns	
		30N60AU1	2.5	mJ	
$t_{d(on)}$	Inductive load, $T_J = 125^\circ\text{C}$ $I_C = I_{C90}$, $V_{GE} = 15 \text{ V}$, $L = 100 \mu\text{H}$, $V_{CE} = 0.8 V_{CES}$, $R_G = 4.7 \Omega$ Remarks: Switching times may increase for V_{CE} (Clamp) $> 0.8 \cdot V_{CES}$, higher T_J or increased R_G	60		ns	
t_{ri}		130		ns	
E_{on}		4.2		mJ	
$t_{d(off)}$		30N60U1	540	1000	ns
		30N60AU1	340	525	ns
t_{fi}		30N60U1	600	1500	ns
E_{off}		30N60AU1	340	700	ns
		30N60U1	12	mJ	
		30N60AU1	6	mJ	
R_{thJC}				0.63	K/W
R_{thCK}			0.25		K/W

TO-247 AD (IXSH) Outline



Dim.	Millimeter Min.	Max.	Inches Min.	Max.
A	19.81	20.32	0.780	0.800
B	20.80	21.46	0.819	0.845
C	15.75	16.26	0.610	0.640
D	3.55	3.65	0.140	0.144
E	4.32	5.49	0.170	0.216
F	5.4	6.2	0.212	0.244
G	1.65	2.13	0.065	0.084
H	-	4.5	-	0.177
J	1.0	1.4	0.040	0.055
K	10.8	11.0	0.426	0.433
L	4.7	5.3	0.185	0.209
M	0.4	0.8	0.016	0.031
N	1.5	2.49	0.087	0.102

Reverse Diode (FRED)

Symbol	Test Conditions	Characteristic Values			
		($T_J = 25^\circ\text{C}$, unless otherwise specified)	min.	typ.	max.
V_F	$I_F = I_{C90}$, $V_{GE} = 0 \text{ V}$, Pulse test, $t \leq 300 \mu\text{s}$, duty cycle $d \leq 2 \%$			1.6	V
I_{RM}	$I_F = I_{C90}$, $V_{GE} = 0 \text{ V}$, $-di_F/dt = 240 \text{ A}/\mu\text{s}$ $V_R = 360 \text{ V}$ $T_J = 125^\circ\text{C}$ $I_F = 1 \text{ A}$; $-di/dt = 100 \text{ A}/\mu\text{s}$; $V_R = 30 \text{ V}$ $T_J = 25^\circ\text{C}$	10	15	A	
t_{rr}		150		ns	
		35	50	ns	
R_{thJC}				1	K/W

Fig.1 Saturation Characteristics

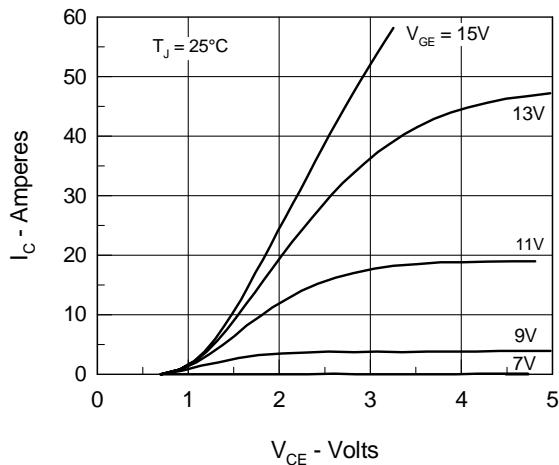


Fig.3 Collector-Emitter Voltage vs. Gate-Emitter Voltage

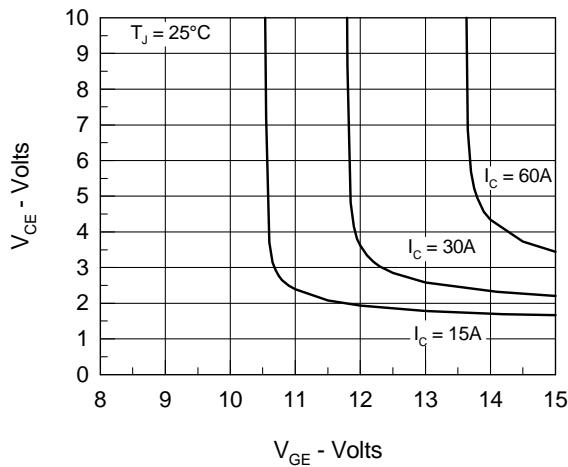


Fig.5 Input Admittance

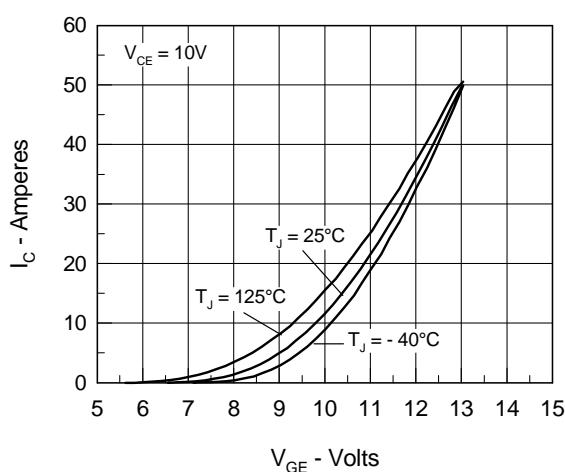


Fig.2 Output Characteristics

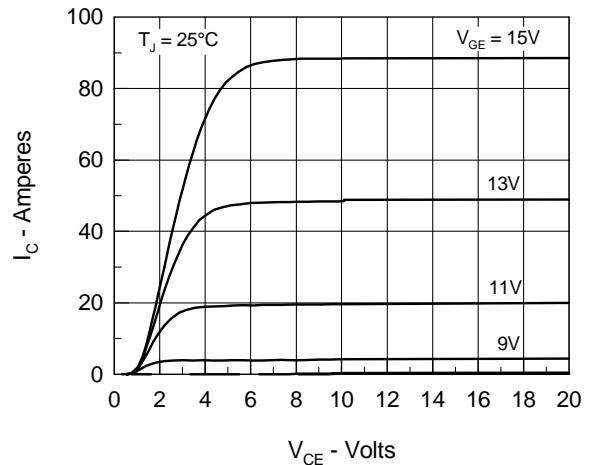


Fig.4 Temperature Dependence of Output Saturation Voltage

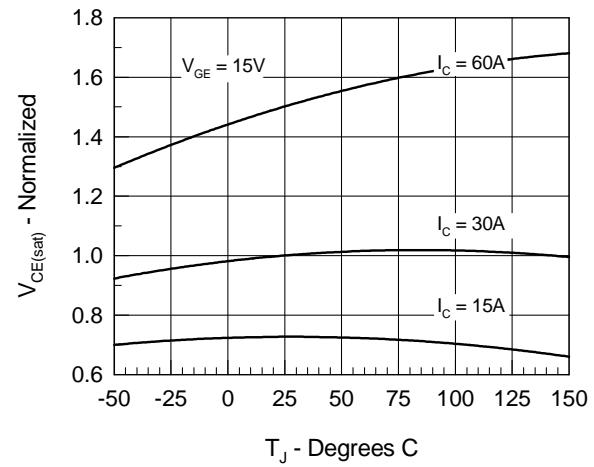


Fig.6 Temperature Dependence of Breakdown and Threshold Voltage

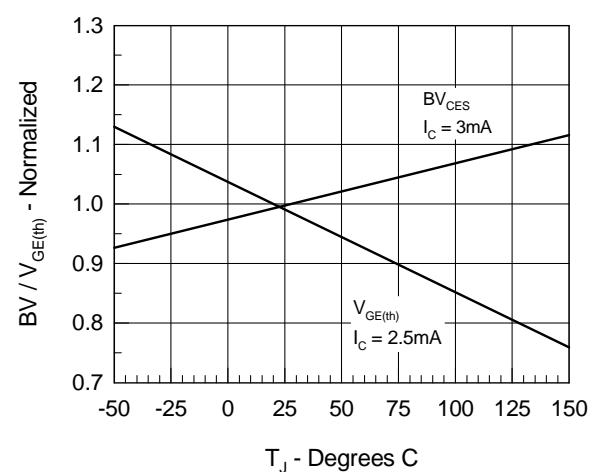


Fig.7 Turn-Off Energy per Pulse and Fall Time on Collector Current

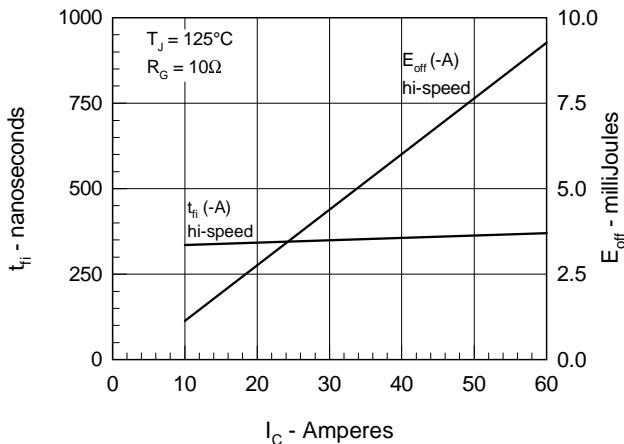
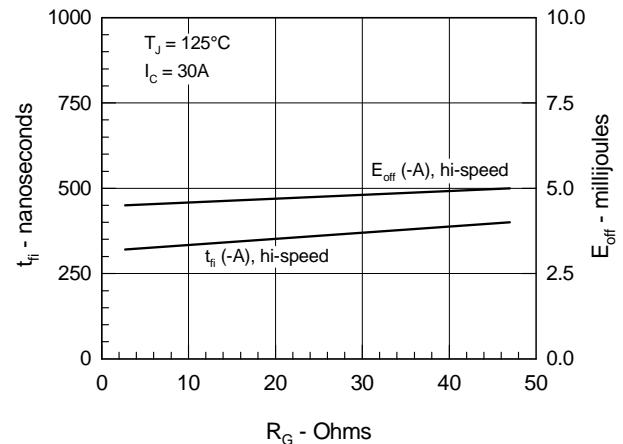
Fig.8 Dependence of Turn-Off Energy Per Pulse and Fall Time on R_G 

Fig.9 Gate Charge Characteristic Curve

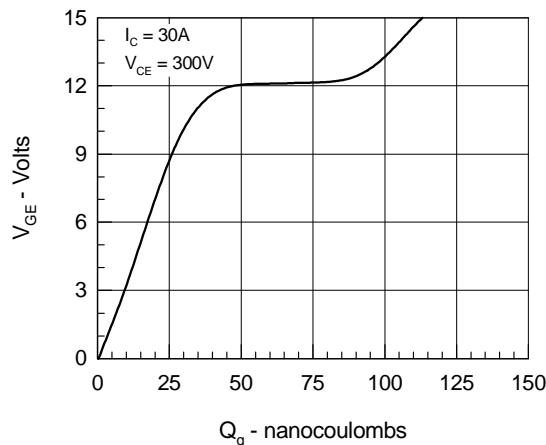


Fig.10 Turn-Off Safe Operating Area

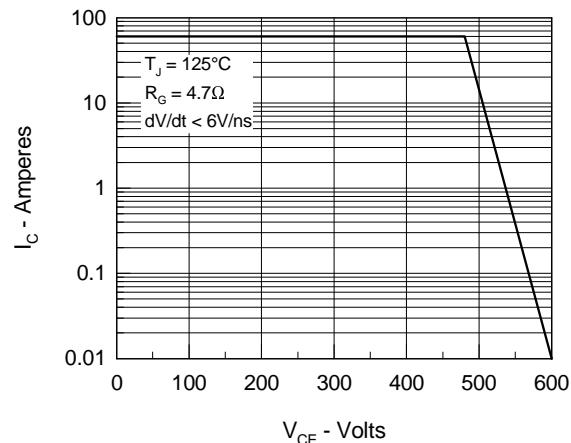


Fig.11 Transient Thermal Impedance

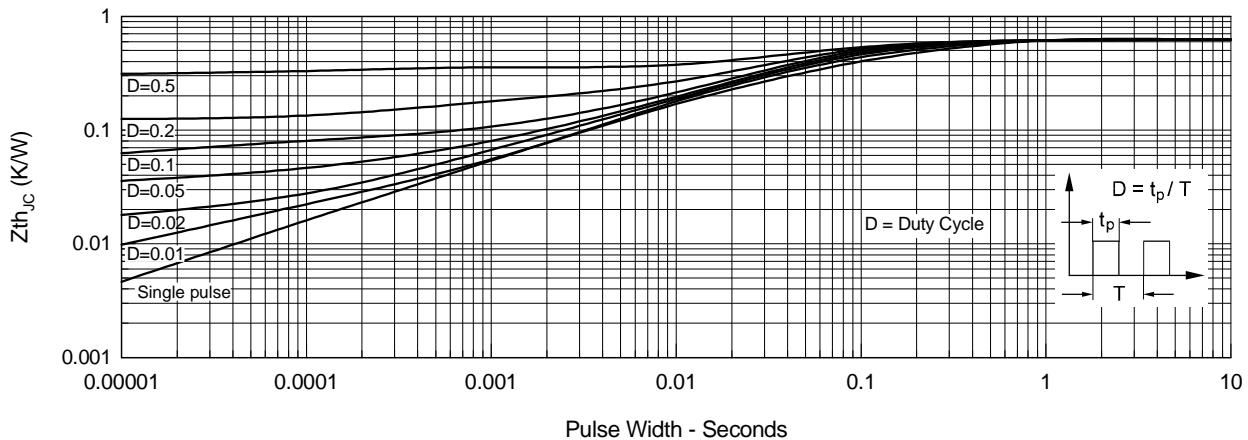


Fig.12 Maximum Forward Voltage Drop

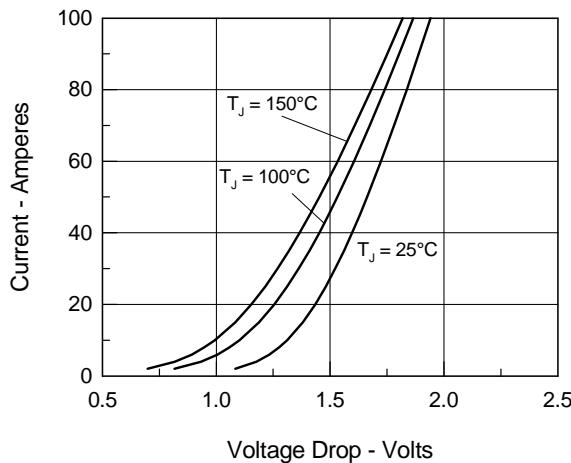
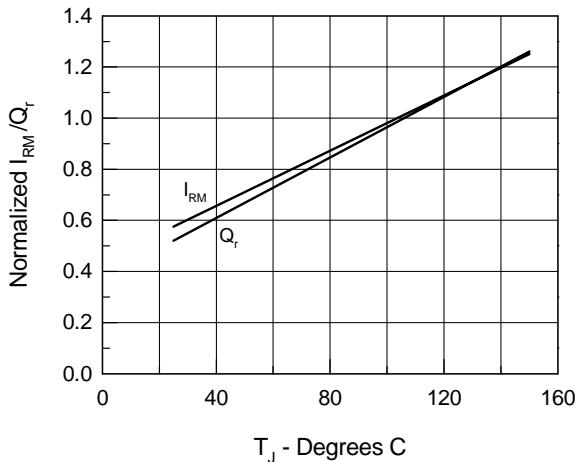
Fig.14 Junction Temperature Dependence off I_{RM} and Q_r 

Fig.16 Peak Reverse Recovery Current

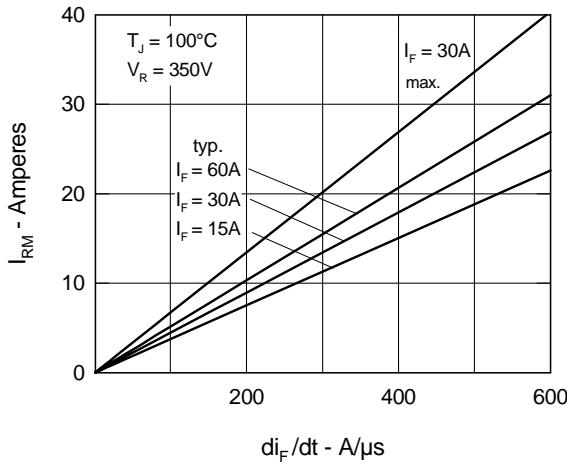
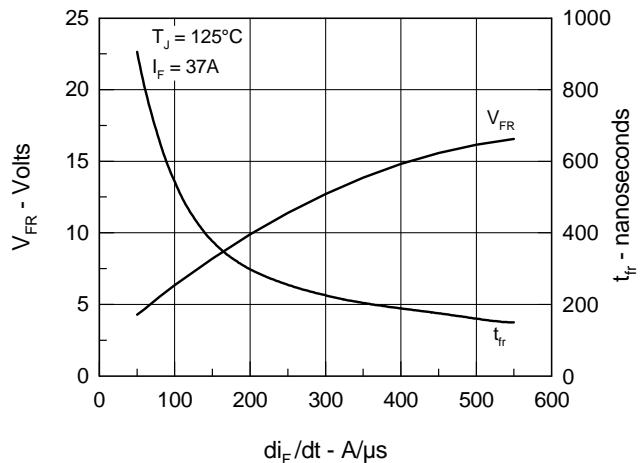
Fig.13 Peak Forward Voltage V_{FR} and Forward Recovery Time t_{fr} 

Fig.15 Reverse Recovery Chargeee

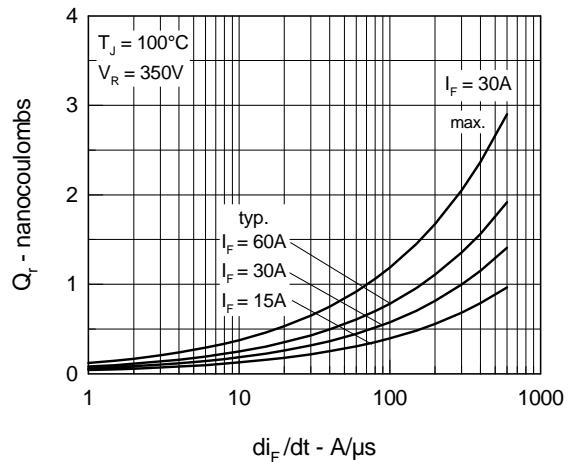


Fig.17 Reverse Recovery Time

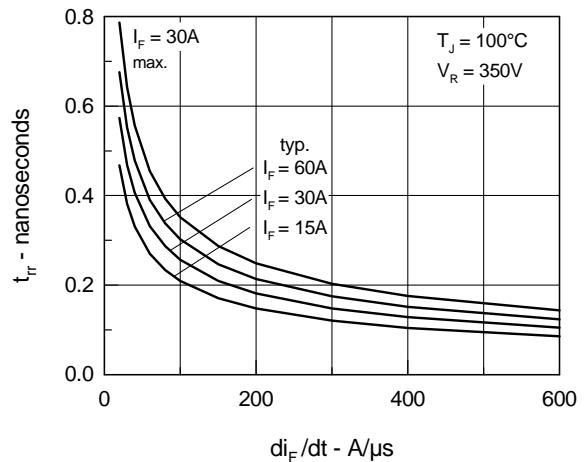


Fig.18 Diode Transient Thermal resistance junction to case

